

ZXTN25040DFL 40V, SOT23, NPN low power transistor

Summary

 $BV_{CEX} > 130V$

 $BV_{CEO} > 40V$

 $BV_{ECO} > 6V$

 $I_{C(cont)} = 1.5A$

V_{CE(sat)} < 85mV @ 1A

 $R_{CE(sat)} = 59m\Omega$

 $P_{D} = 350 \text{mW}$

Complementary part number ZXTP25040DFL



Advanced process capability has been used to achieve high current gain hold up making this device ideal for applications requiring high pulse currents.

Features

- · High peak current
- · Low saturation voltage
- 130V forward blocking voltage
- 6V reverse blocking voltage

Applications

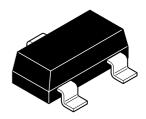
- · MOSFET and IGBT gate driving
- · DC-DC conversion
- · LED driving
- · Interface between low voltage IC's and loads

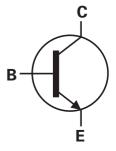
Ordering information

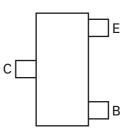
Device	Reel size (inches)	Tape width (mm)	Quantity per reel	
ZXTN25040DFLTA	7	8	3000	

Device marking

1B7







Pinout - top view

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V _{CBO}	130	V
Collector-emitter voltage (forward blocking)	V _{CEX}	130	V
Collector-emitter voltage	V _{CEO}	40	V
Emitter-collector voltage (reverse blocking)	V _{ECO}	6	V
Emitter-base voltage	V _{EBO}	7	V
Continuous collector current ^(a)	I _C	1.5	Α
Base current	I _B	0.5	Α
Peak pulse current	I _{CM}	6	Α
Power dissipation at T _{amb} = 25°C ^(a)	P _D	350	mW
Linear derating factor		2.8	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

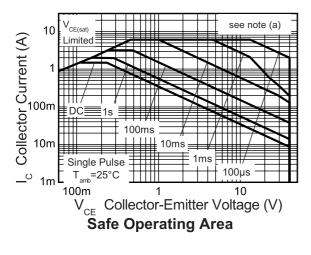
Thermal resistance

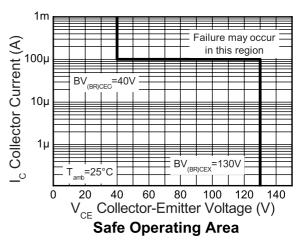
Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	357	°C/W

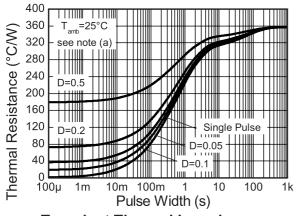
NOTES:

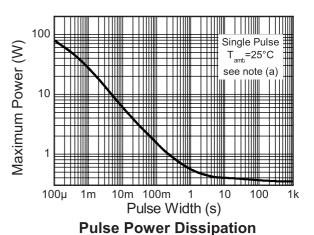
⁽a) For a device surface mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

Characteristics

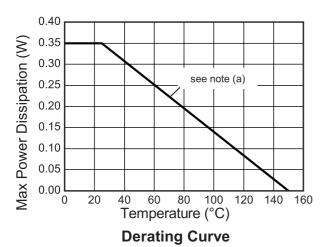








Transient Thermal Impedance



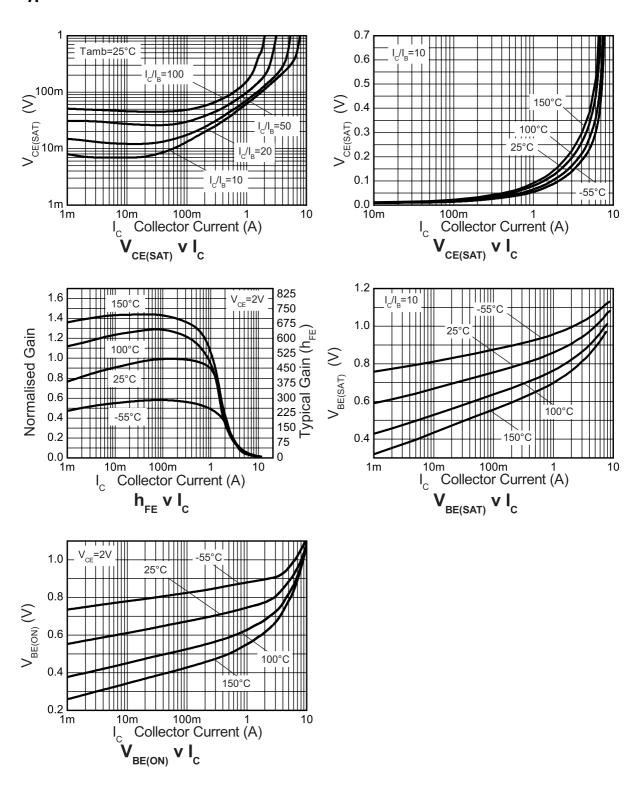
Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV _{CBO}	130	170		V	$I_C = 100 \mu A$
Collector-emitter breakdown voltage (forward blocking)	BV _{CEX}	130	170		V	I_C = 100 μ A; R_{BE} < 1k Ω or -1V < V_{BE} < 0.25V
Collector-emitter breakdown voltage (base open)	BV _{CEO}	40	63		V	I _C = 10mA ^(*)
Emitter-base breakdown voltage	BV _{EBO}	7	8.3		V	$I_E = 100 \mu A$
Emitter-collector breakdown voltage (reverse blocking)	BV _{ECX}	6	7.4		V	I_E = 100μA, R_{BC} < 1kΩ or 0.25V > V_{BC} > -0.25V
Emitter-collector breakdown voltage (base open)	BV _{ECO}	6	7.4		V	$I_E = 100 \mu A$,
Collector cut-off current	I _{CBO}		<1	50 20	nA μA	V _{CB} = 100V V _{CB} = 100V, T _{amb} = 100°C
Collector emitter cut-off current	I _{CEX}		<1	100	nA	$V_{CE} = 100V; R_{BE} < 1k\Omega \text{ or}$ -1V < $V_{BE} < 0.25V$
Emitter cut-off current	I _{EBO}		<1	50	nA	V _{EB} = 5.6V
Collector-emitter saturation	V _{CE(sat)}		35	50	mV	$I_C = 0.5A, I_B = 50mA^{(*)}$
voltage			60	80	mV	$I_C = 0.5A, I_B = 10mA^{(*)}$
			70	85	mV	$I_C = 1A$, $I_B = 100mA$
			145	185	mV	$I_C = 1.5A$, $I_B = 30mA^{(*)}$
			235	285	mV	$I_C = 4A$, $I_B = 400 \text{mA}^{(*)}$
Base-emitter saturation voltage	V _{BE(sat)}		840	950	mV	$I_C = 1.5A$, $I_B = 30mA^{(*)}$
Base-emitter turn-on voltage	V _{BE(on)}		770	850	mV	$I_C = 1.5A, V_{CE} = 2V^{(*)}$
Static forward current	h _{FE}	300	450	900		I _C = 10mA, V _{CE} = 2V ^(*)
transfer ratio		300	400			$I_C = 1A$, $V_{CE} = 2V^{(*)}$
		170	250			$I_C = 1.5A, V_{CE} = 2V^{(*)}$
		25	40			$I_C = 4A, V_{CE} = 2V^{(*)}$
Transition frequency	f _T		190		MHz	$I_C = 50 \text{mA}, V_{CE} = 10 \text{V}$ f = 100MHz
Output capacitance	C _{obo}		11.7	20	pF	V _{CB} = 10V, f = 1MHz ^(*)
Delay time	t _(d)		64		ns	V _{CC} = 10V,
Rise time	t _(r)		108		ns	I _C = 1A,
Storage time	t _(s)		428		ns	$I_{B1} = I_{B2} = 10 \text{mA}.$
Fall time	t _(f)		130		ns	

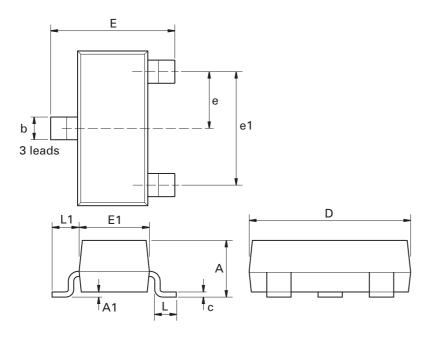
NOTES

(*) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.

Typical characteristics



Package outline - SOT23



Dim.	Millim	neters	Inches Di		Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Мах.	Max.
Α	2.67	3.05	0.105	0.120	Н	0.33	0.51	0.013	0.020
В	1.20	1.40	0.047	0.055	K	0.01	0.10	0.0004	0.004
С	-	1.10	-	0.043	L	2.10	2.50	0.083	0.0985
D	0.37	0.53	0.015	0.021	M	0.45	0.64	0.018	0.025
F	0.085	0.15	0.0034	0.0059	N	0.95 N	IOM	0.0375	NOM
G	1.90	NOM	0.075	NOM	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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